

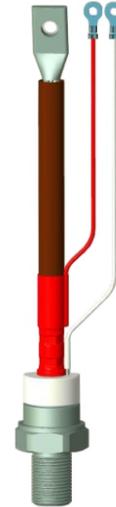
## Phase Control Thyristors (Stud Version), 230A

### FEATURES

- Center amplifying gate
- Metal case with ceramic insulator
- International standard case TO-209AB (TO-93),
- Lead (Pb)-free
- Compression bonded encapsulation for heavy duty operation such as severe thermal cycling
- Designed and qualified for industrial level

### TYPICAL APPLICATIONS

- DC motor controls
- Controlled DC power supplies
- AC controllers



TO-209AB(TO-93)

PRODUCT SUMMARY	
$I_{T(AV)}$	230A
$V_{DRM}/V_{RRM}$	400V to 2000V
$V_{TM}$	1.55V
$I_{GT}$	120mA
$T_J$	-40°C to 125°C
Package	TO-209AB (TO-93)
Diode variation	Single SCR

MAJOR RATINGS AND CHARACTERISTICS			
PARAMETER	TEST CONDITIONS	VALUES	UNIT
$I_{T(AV)}$		230	A
	$T_c$	85	°C
$I_{T(RMS)}$		360	A
$I_{TSM}$	50 HZ	5700	A
	60 HZ	5970	
$I^2t$	50 HZ	163	kA <sup>2</sup> s
	60 HZ	148	
$V_{DRM}/V_{RRM}$		400 to 2000	V
$t_q$	Typical	100	µs
$T_J$		-40 to 125	°C

### ELECTRICAL SPECIFICATIONS

VOLTAGE RATINGS				
TYPE NUMBER	VOLTAGE CODE	$V_{DRM}/V_{RRM}$ , MAXIMUM REPETITIVE PEAK AND OFF-STATE VOLTAGE V	$V_{RSM}$ , MAXIMUM NON-REPETITIVE PEAK REVERSE VOLTAGE V	$I_{DRM}/I_{RRM}$ , MAXIMUM AT $T_J = T_J$ MAXIMUM mA
230PTxxSC	04	400	500	30
	08	800	900	
	12	1200	1300	
	16	1600	1700	
	20	2000	2100	

FORWARD CONDUCTION					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUES	UNIT
Maximum average current at heatsink temperature	$I_{T(AV)}$	180° conduction, half sine wave		230	A
				85	°C
Maximum RMS on-state current	$I_{T(RMS)}$	DC at 78°C case temperature		360	A
Maximum peak, one cycle non-repetitive surge current	$I_{TSM}$	t = 10ms	No voltage reapplied	5700	A
		t = 8.3ms		5970	
		t = 10ms	100% $V_{RRM}$ reapplied	4790	
		t = 8.3ms		5010	
Maximum $I^2t$ for fusing	$I^2t$	t = 10ms	No voltage reapplied	163	$kA^2s$
		t = 8.3ms		148	
		t = 10ms	100% $V_{RRM}$ reapplied	115	
		t = 8.3ms		104	
Maximum $I^2\sqrt{t}$ for fusing	$I^2\sqrt{t}$	t = 0.1 to 10 ms, no voltage reapplied		1625	$kA^2\sqrt{s}$
Low level value of threshold voltage	$V_{T(TO)1}$	$(16.7\% \times \pi \times I_{T(AV)} < I < \pi \times I_{T(AV)})$ , $T_J = T_J$ maximum		0.92	V
High level value of threshold voltage	$V_{T(TO)2}$	$(I > \pi \times I_{T(AV)})$ , $T_J = T_J$ maximum		0.98	
Low level value on-state slope resistance	$r_{t1}$	$(16.7\% \times \pi \times I_{T(AV)} < I < \pi \times I_{T(AV)})$ , $T_J = T_J$ maximum		0.88	mΩ
High level value on-state slope resistance	$r_{t2}$	$(I > \pi \times I_{T(AV)})$ , $T_J = T_J$ maximum		0.81	
Maximum on-state voltage	$V_{TM}$	$I_{pk} = 720A$ , $T_J = T_J$ maximum, $t_p = 10$ ms sine pulse		1.55	V
Maximum holding current	$I_H$	$T_J = 25^\circ C$ , anode supply 12V resistive load		200	mA
Maximum (Typical) latching current	$I_L$			300(200)	

SWITCHING					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUES	UNIT
Maximum non-repetitive rate of rise of turned-on current	$di/dt$	Gate drive 20V, 20Ω, $t_r \leq 1\mu s$ $T_J = T_J$ maximum, anode voltage $\leq 80\% V_{DRM}$		1000	A/μs
Typical delay time	$t_d$	Gate current 1A, $di_g/dt = 1$ A/μs $V_D = 0.67 V_{DRM}$ , $T_J = 25^\circ C$		1.0	μs
Typical turn-off time	$t_q$	$I_{TM} = 300A$ , $T_J = T_J$ maximum, $di/dt = 20A/\mu s$ . $V_R = 50V$ , $dV/dt = 20$ V/μs, gate 0 V 100Ω, $t_p = 500\mu s$		100	

BLOCKING					
PARAMETER	SYMBOL	TEST CONDITIONS		VALUES	UNIT
Maximum critical rate of rise of off-state voltage	$dV/dt$	$T_J = T_J$ maximum linear to 80% rated $V_{DRM}$		500	V/μs
Maximum peak reverse and off-state leakage current	$I_{RRM}$ , $I_{DRM}$	$T_J = T_J$ maximum, rated $V_{DRM}/V_{RRM}$ applied		30	mA

TRIGGERING						
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES		UNIT	
			TYP.	MAX.		
Maximum peak gate power	$P_{GM}$	$T_J = T_J$ maximum, $t_p \leq 5$ ms	10		W	
Maximum average gate power	$P_{G(AV)}$	$T_J = T_J$ maximum, $f = 50$ Hz, $d\% = 50$	2			
Maximum peak positive gate current	$I_{GM}$	$T_J = T_J$ maximum, $t_p \leq 5$ ms	3		A	
Maximum peak positive gate voltage	$+V_{GM}$	$T_J = T_J$ maximum, $t_p \leq 5$ ms	20		V	
Maximum peak negative gate voltage	$-V_{GM}$		5			
DC gate current required to trigger	$I_{GT}$	$T_J = -40^\circ\text{C}$	140	-	mA	
		$T_J = 25^\circ\text{C}$	70	120		
		$T_J = 125^\circ\text{C}$	30	-		
DC gate voltage required to trigger	$V_{GT}$	$T_J = -40^\circ\text{C}$	1.8	-	V	
		$T_J = 25^\circ\text{C}$	1.2	2.0		
		$T_J = 125^\circ\text{C}$	0.8	-		
DC gate current not to trigger	$I_{GD}$	$T_J = T_J$ maximum	Maximum gate current/voltage not to trigger is the maximum value which will not trigger any unit with rated $V_{DRM}$ anode to cathode applied		10	mA
DC gate voltage not to trigger	$V_{GD}$		0.25	V		

THERMAL AND MECHANICAL SPECIFICATIONS				
PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNIT
Maximum operating junction temperature range	$T_J$		-40 to 125	°C
Maximum storage temperature range	$T_{stg}$		-40 to 150	
Maximum thermal resistance, junction to case	$R_{thJC}$	DC operation	0.10	K/W
Maximum thermal resistance, case to heatsink	$R_{thC-hs}$	Mounting surface, smooth, flat and greased	0.04	
Mounting force, $\pm 10\%$		Non-lubricated threads	31(275)	N.m (lbf.in)
		Lubricated threads	24.5(210)	
Approximate weight			280	g
Case style		TO-209AB (TO-93)		

$\Delta R_{thJC}$ CONDUCTION				
CONDUCTION ANGEL	SINUSOIDAL CONDUCTION	RECTANGULAR CONDUCTION	TEST CONDUCTIONS	UNITS
180°	0.016	0.012	$T_J = T_J$ maximum	K/W
120°	0.019	0.020		
90°	0.025	0.027		
60°	0.036	0.037		
30°	0.060	0.060		

**Note**

• The table above shows the increment of thermal resistance  $R_{thJC}$  when devices operate at different conduction angles than DC

Fig.1 Current ratings characteristics

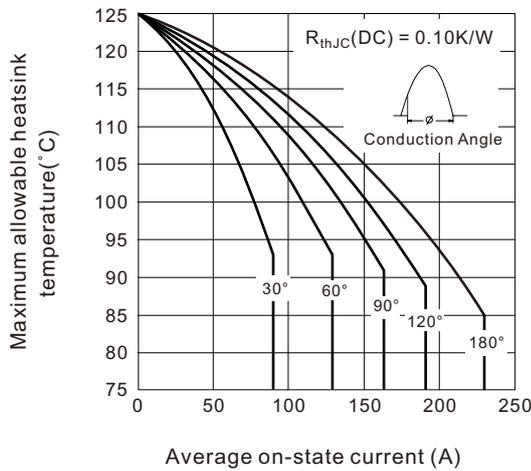


Fig.2 Current ratings characteristics

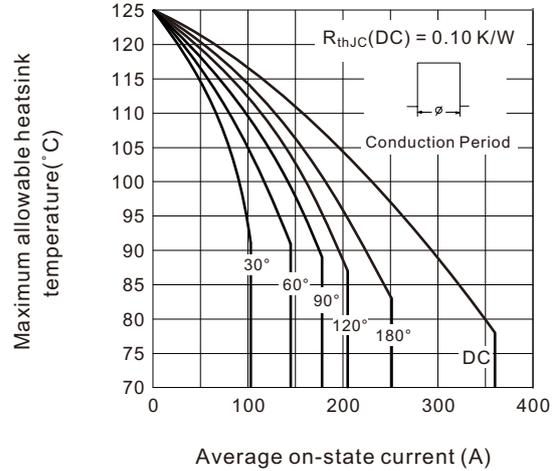


Fig.3 On-state power loss characteristics

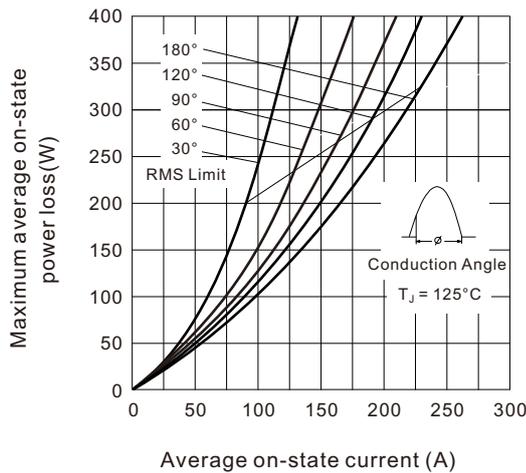


Fig.4 On-state power loss characteristics

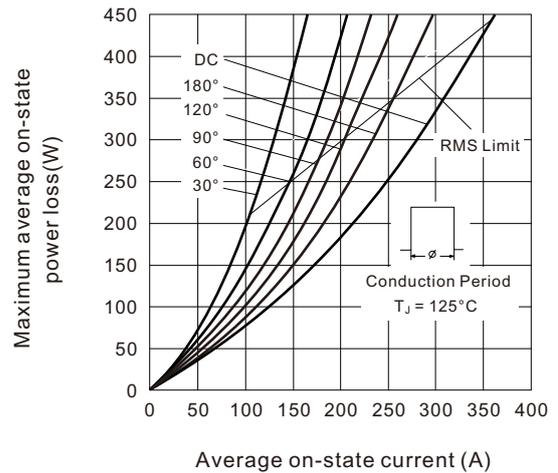


Fig.5 Maximum non-repetitive surge current single and double side cooled

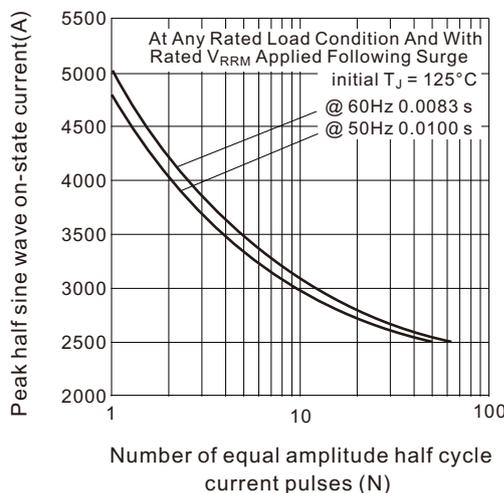


Fig.6 Maximum non-repetitive surge current single and double side cooled

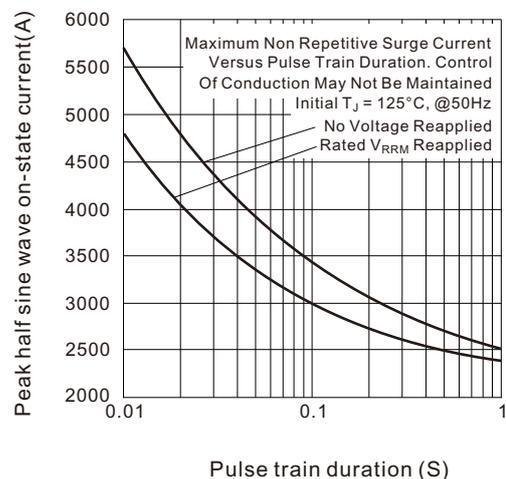


Fig.7 On-state voltage drop characteristics

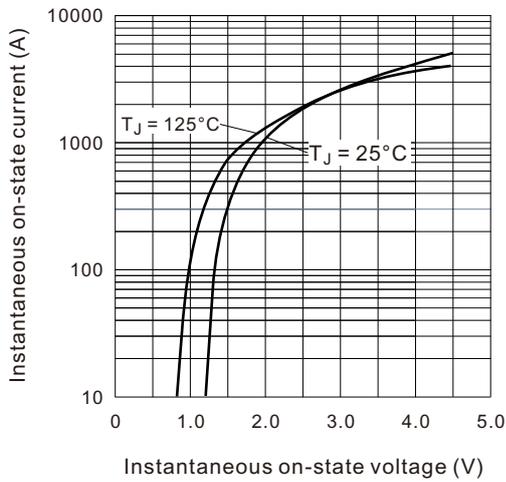


Fig.8 Thermal Impedance  $Z_{thJC}$  characteristics

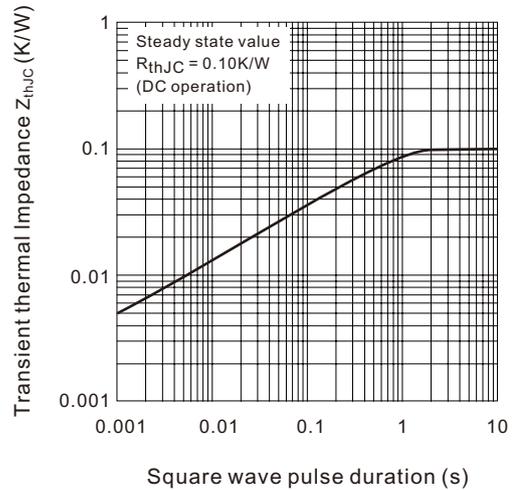
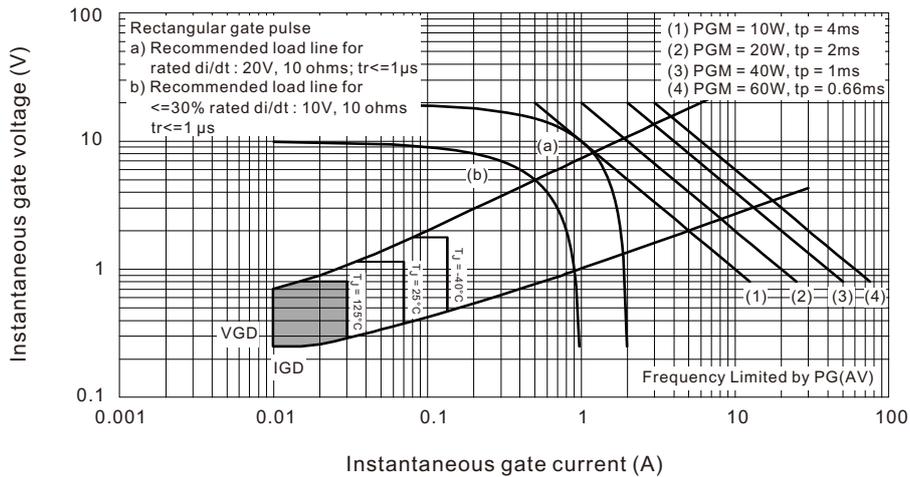


Fig.9 Gate characteristics

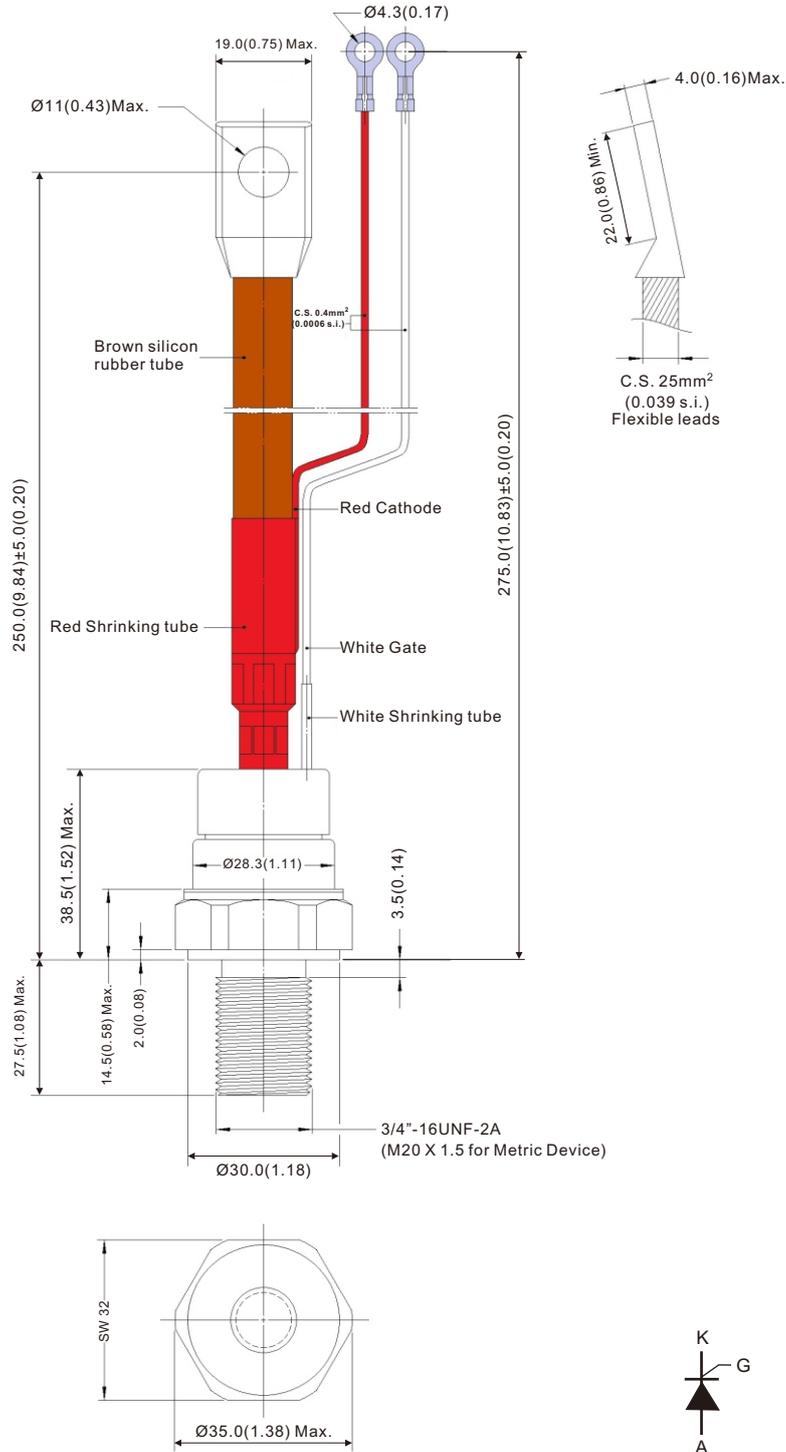


### ORDERING INFORMATION TABLE

Device code	<b>230</b>	<b>PT</b>	<b>16</b>	<b>S</b>	<b>C</b>
	①	②	③	④	⑤

- ① - Maximum average on-state current  $I_{T(AV)}$ , 230 for 230A
- ② - PT = Phase Control Thyristors
- ③ - Voltage code, cold  $\times 100 = V_{RRM}/V_{RRM}$
- ④ - S = Stud product
- ⑤ - C = TO-209AB (TO-93), pressure contact type (Compression bonded)

## TO-209AB (TO-93) Ceramic Housing (Inner Pressure Contact Structure)



All dimensions in millimeters(inches)